## Notice of References Cited Application/Control No. 10/623,320 Examiner Nhan T. Tran Applicant(s)/Patent Under Reexamination ICHIKAWA ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,249,276	07-2007	Meese, Rupert	370/225
	В	US-			
	C	US-			
	۵	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	<i>;</i>	US-			
	7	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	WO 02/098074	12-2002	PCT WO	RUPERT MEESE	H04L 12/56
	0					
	Р					
	Q					
	R					
	s					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	x					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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